

2SD1802

NPN SILICON TRANSISTOR

HIGH CURRENT SWITCHING APPLICATION

DESCRIPTION

The UTC **2SD1802** applies to voltage regulators, relay drivers, lamp drivers and electrical equipment.

FEATURES

- * Adoption of FBET, MBIT processes
- * Large current capacity and wide ASO
- * Low collector-to-emitter saturation voltage
- * Fast switching speed

TO-251

ORDERING INFORMATION

Ordering	Deekege	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing
2SD1802L-x-TM3-T	2SD1802G-x-TM3-T	TO-251	В	С	E	Tube
2SD1802L-x-TN3-T	2SD1802G-x-TN3-T	TO-252	В	С	E	Tube
2SD1802L-x-TN3-R	2SD1802G-x-TN3-R	TO-252	В	С	Е	Tape Reel
Note: Pin Assignment: B: Base						

2SD1802L-x-TM3-T (1)Packing Type (2)Package Type	 (1) T: Tube, R: Tape Reel (2) TM3: TO-251, TN3: TO-252 (3) x: refer to Classification of h_{FE} 				
(3)Rank (4)Lead Free	(4) G: Halogen Free, L: Lead Free				

■ ABSOLUTE MAXIMUM RATING (T_A= 25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Collector-Base Voltage	V _{CBO}	60	V	
Collector-Emitter Voltage	V _{CEO}	50	V	
Emitter-Base Voltage	V _{EBO}	6	V	
Collector Power Dissipation		1		
Tc=25℃	P _c	15	W	
Collector Current (DC)	lc	3	А	
Collector Current (PULSE)	I _{CP}	6	А	
Junction Temperature	TJ	150	°C	
Storage Temperature	T _{STG}	-55 ~ +150	°C	

Note 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. The device is guaranteed to meet performance specification within 0°C ~70°C operating temperature range and assured by design from −20°C ~85°C.

■ ELECTRICAL CHARACTERISTICS (T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Collector Cutoff Current	I _{CBO}	V _{CB} =40V, I _E =0			1	μA
Emitter Cutoff Current	I _{EBO}	V_{EB} =4V, I _C =0			1	μA
DC Current Gain (note)	h _{FE1}	V _{CE} =2V, I _C =100mA	100		560	
	h _{FE2}	$V_{CE}=2V$, $I_{C}=3A$	35			
Gain-Bandwidth Product	f⊤	V _{CE} =10V, I _C =50mA		150		MHz
Output Capacitance	Сов	V _{CB} =10V, f=1MHz		25		рF
C-E Saturation Voltage	V _{CE(SAT)}	I _C = 2A, I _B =100mA		0.19	0.5	V
B-E Saturation Voltage	V _{BE(SAT)}	I _C = 2A, I _B =100mA		0.94	1.2	V
C-B Breakdown Voltage	V _{(BR)CBO}	I _C = 10μA, I _E =0	60			V
C-E Breakdown Voltage	V _{(BR)CEO}	I _C = 1mA, R _{BE} =∞	50			V
E-B Breakdown Voltage	V _{(BR)EBO}	I _E = 10μA, I _C =0	6			V
Turn-on Time	t _{ON}	See test circuit		70		ns
Storage Time	t _{stg}	See test circuit		650		ns
Fall Time	t _F	See test circuit		35		ns

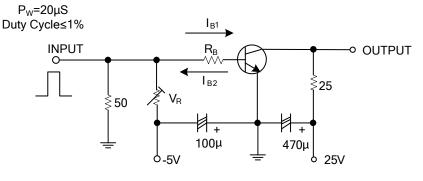
CLASSIFICATION OF h_{FE1}

RANK	R	S	Т	U
RANGE	100-200	140-280	200-400	280-560



2SD1802

TEST CIRCUIT (Unit : resistance : Ω, capacitance : F)



Ic=10I_{B1}= -10I_{B2}=1A

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